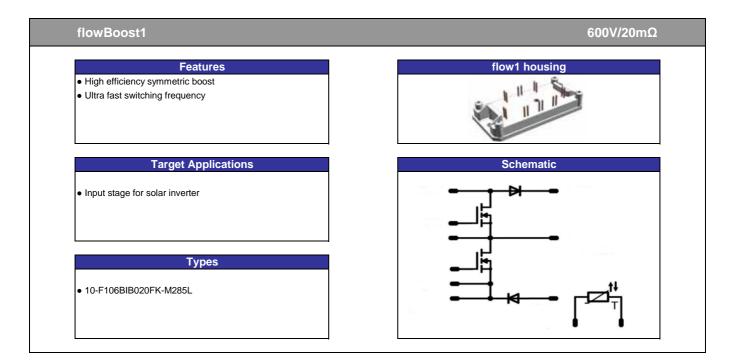


Tj=25°C, unless otherwise specified



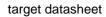
Maximum Ratings

Parameter	Symbol	Conditi	on	Value	Unit
Input Boost MOSFET					
Drain to source breakdown voltage	V _{DS}			650	V
DC drain current	I _D	T _j =T _j max	T _h =25°C T _h =80°C	100 75	Α
Pulsed drain current	I _{Dpulse}	t _p limited by T _j max		400	А
Power dissipation	P _{tot}	T _j =T _j max	T _h =25°C T _h =80°C	329 184	W
Gate-source peak voltage	V_{GS}			25	٧
Maximum Junction Temperature	T _j max			150	°C
				•	

Input Boost Diode						
Peak Repetitive Reverse Voltage	V_{RRM}	T _j =25°C		600	٧	
DC forward current	I _F	T _j =T _j max	T _h =25°C T _h =80°C	115 77	Α	
Repetitive peak forward current	I _{FRM}	t _p limited by T _j max		240	А	
Power dissipation	P _{tot}	T _j =T _j max	T _h =25°C T _h =80°C	179 100	W	
Maximum Junction Temperature	T _j max			150	°C	

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Maximum Ratings

Tj=25°C, unless otherwise specified

Parameter	Symbol	Condition	Value	Unit
Thermal Properties				
Storage temperature	T _{stg}		-40+125	°C
Operation temperature under switching condition	T _{op}		-40+(Tjmax - 25)	°C
Insulation Properties				
Insulation voltage	V _{is}	t=2s DC voltage	4000	V
Creepage distance			min 12,7	mm
Clearance			min 12,7	mm



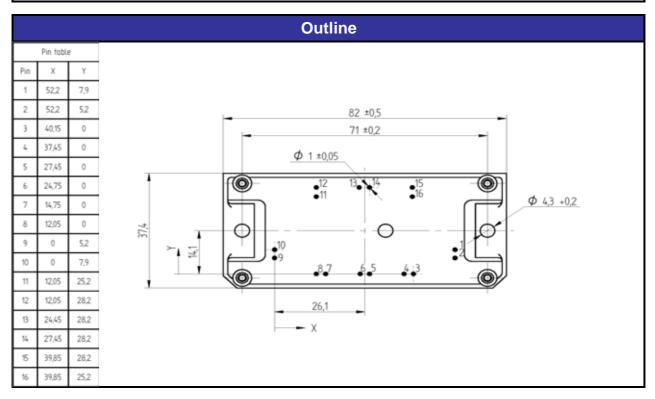
Characteristic Values

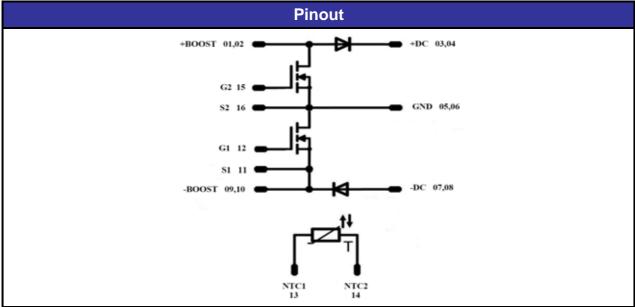
Parameter	Symbol Conditions			Value			Unit			
			V _{GE} [V] or V _{GS} [V]	V _r [V] or V _{CE} [V] or V _{DS} [V]	I _C [A] or I _F [A] or I _D [A]	T _j	Min	Тур	Max	
Input Boost MOSFET										
Static drain to source ON resistance	R _{DS(on)}				69	Tj=25°C Tj=125°C		0,019 0,038		Ω
Gate threshold voltage	V _{(GS)th}	VGS=VDS			0,0005	Tj=25°C Tj=125°C	3	4	5	٧
Gate to Source Leakage Current	I _{gss}		20	0		Tj=25°C Tj=125°C			400	nA
Zero Gate Voltage Drain Current	I _{dss}		0	650		Tj=25°C Tj=125°C			2 200	μA
Turn On Delay Time	t _{d(ON)}					Tj=25°C Tj=125°C		36	200	
Rise Time	t _r	Rgoff=2,4 Ω Rgon=2,4 Ω	10	400		Tj=25°C Tj=125°C		90		
Turn off delay time	t _{d(OFF)}					Tj=25°C Tj=125°C		130		ns
Fall time	t _f				80	Tj=25°C Tj=125°C		40		
Turn-on energy loss per pulse	Eon					Tj=25°C Tj=125°C		tbd		mWs
Turn-off energy loss per pulse	E _{off}					Tj=125°C Tj=25°C Tj=125°C		tbd		
Total gate charge	Qg					Tj=125 °C Tj=25 °C Tj=125 °C		360		
Gate to source charge	Q_{gs}		10	520	69	Tj=25°C		120		nC
Gate to drain charge	Q _{gd}					Tj=125°C Tj=25°C		140		
Input capacitance	C _{iss}					Tj=125°C		19600		
Output capacitance	C _{oss}	f=1MHz	0	100		Tj=25°C		400		pF
Reverse transfer capacitance	C _{rss}						12			
Thermal resistance chip to heatsink per chip	R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK						0,38		K/W
Input Boost Diode										
Forward voltage	V _F				120	Tj=25°C		1,4		V
Reverse leakage current	I _{rm}			390	120	Tj=125°C Tj=25°C		1,3	200	μA
Peak recovery current					-	Tj=125°C				
						Tj=25°C		11	1000	
Reverse recovery time	I _{RRM}					Tj=125°C Tj=25°C		25 60	1000	A
Reverse recovery time Reverse recovery charge	t _{rr}	diF/dt = 200 A/us		390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C		25	1000	A
Reverse recovery charge	t _{rr} Q _{rr}	diF/dt = 200 A/us		390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=25°C		25 60 138	1000	A ns μC
Reverse recovery charge Reverse recovered energy	t _{rr} Q _{rr} E _{rec} di(rec)max			390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=125°C Tj=25°C		25 60 138 tbd	1000	A ns μC mWs
Reverse recovery charge	t _{rr} Q _{rr} E _{rec}			390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=25°C Tj=25°C		25 60 138 tbd	1000	A ns μC
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip	t _{rr} Q _{rr} E _{rec} di(rec)max /dt	Thermal grease thickness≤50um		390	120	Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=25°C Tj=125°C Tj=125°C Tj=25°C		25 60 138 tbd tbd	1000	A ns μC mWs A/μs
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um		390	120	Ti=125°C Ti=25°C		25 60 138 tbd tbd tbd	1000	A ns μC mWs A/μs
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK		390	120	Ti=125°C Ti=25°C		25 60 138 tbd tbd		A ns μC mWs A/μs K/W
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance Deviation of R100	$\begin{array}{c} t_{rr} \\ Q_{rr} \\ \\ E_{rec} \\ \hline di(rec)max \\ /dt \\ \\ R_{thJH} \\ \\ \\ R \\ \Delta R/R \\ \end{array}$	Thermal grease thickness≤50um		390	120	Ti=125°C Ti=25°C Ti=125°C Ti=125°C	-5	25 60 138 tbd tbd tbd 0,70	5	A ns μC mWs A/μs K/W
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance Deviation of R100 Power dissipation	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK		390	120	Ti=125°C Ti=25°C T=100°C T=25°C	-5	25 60 138 tbd tbd tbd 0,70		A ns μC mWs A/μs K/W
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance Deviation of R100 Power dissipation Power dissipation constant	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK		390	120	Ti=125°C Ti=25°C	-5	25 60 138 tbd tbd tbd 0,70		A ns μC mWs A/μs K/W Ω mW/K
Reverse recovery charge Reverse recovered energy Peak rate of fall of recovery current Thermal resistance chip to heatsink per chip Thermistor Rated resistance Deviation of R100 Power dissipation	t _{rr} Q _{rr} E _{rec} di(rec)max /dt R _{thJH}	Thermal grease thickness≤50um λ = 1 W/mK R100=1486 Ω Tol. ±3%		390	120	Ti=125°C Ti=25°C T=100°C T=25°C	-5	25 60 138 tbd tbd tbd 0,70		A ns μC mWs A/μs K/W



Ordering Code and Marking - Outline - Pinout

Ordering Code & Marking			
Version Persion	Ordering Code	in DataMatrix as	in packaging barcode as
without thermal paste 17mm housing	10-F106BIB020FK-M285L	M285L	M285L







PRODUCT STATUS DEFINITIONS

Datasheet Status	Product Status	Definition
Target	Formative or In Design	This datasheet contains the design specifications for product development. Specifications may change in any manner without notice. The data contained is exclusively intended for technically trained staff.
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